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Application/Control No.	Applicant(s)/Patent under Reexamination
10/682,518	SHAKUDA ET AL.
Examiner	Art Unit
Wai Sing Louis	2814

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Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)		)
	DATE	EXMR
257/13,79,81,85,86,94,99,102,103,91 8	8/3/2005	WSL
LED, refractive index, first/second clad layer, window layer, bandgap	8/3/2005	WSL